



MIC59P60

8-Bit Serial-Input Protected Latched Driver

General Description

The MIC59P60 serial-input latched driver is a high-voltage (80V), high-current (500mA) integrated circuit comprised of eight CMOS data latches, a bipolar Darlington transistor driver for each latch, and CMOS control circuitry for the common CLEAR, STROBE, CLOCK, SERIAL DATA INPUT, and OUTPUT ENABLE functions. Additional protection circuitry supplied on this device includes thermal shutdown, undervoltage lockout (UVLO), and overcurrent shutdown.

The bipolar/CMOS combination provides an extremely low-power latch with maximum interface flexibility. The MIC59P60 has open-collector outputs capable of sinking 500mA, and integral diodes for inductive load transient suppression with a minimum output breakdown voltage rating of 80V (50V sustaining). The drivers can be operated with a split supply, where the negative supply is down to -20V and may be paralleled for higher load current capability.

Using a 5V logic supply, the MIC59P60 will typically operate at better than 5MHz. With a 12V logic supply, significantly higher speeds can be obtained. The CMOS inputs are compatible with standard CMOS, PMOS, and NMOS circuits. TTL circuits may require pull-up resistors. By using the serial data output, drivers may be cascaded for interface applications requiring additional drive lines.

Each of the eight outputs has an independent overcurrent shutdown of 500mA. Upon over-current shutdown, the affected channel will turn OFF, and the flag will go low until V_{DD} is cycled or the ENABLE/RESET pin is pulsed high. Current pulses less than 2 μ s will not activate current shutdown.

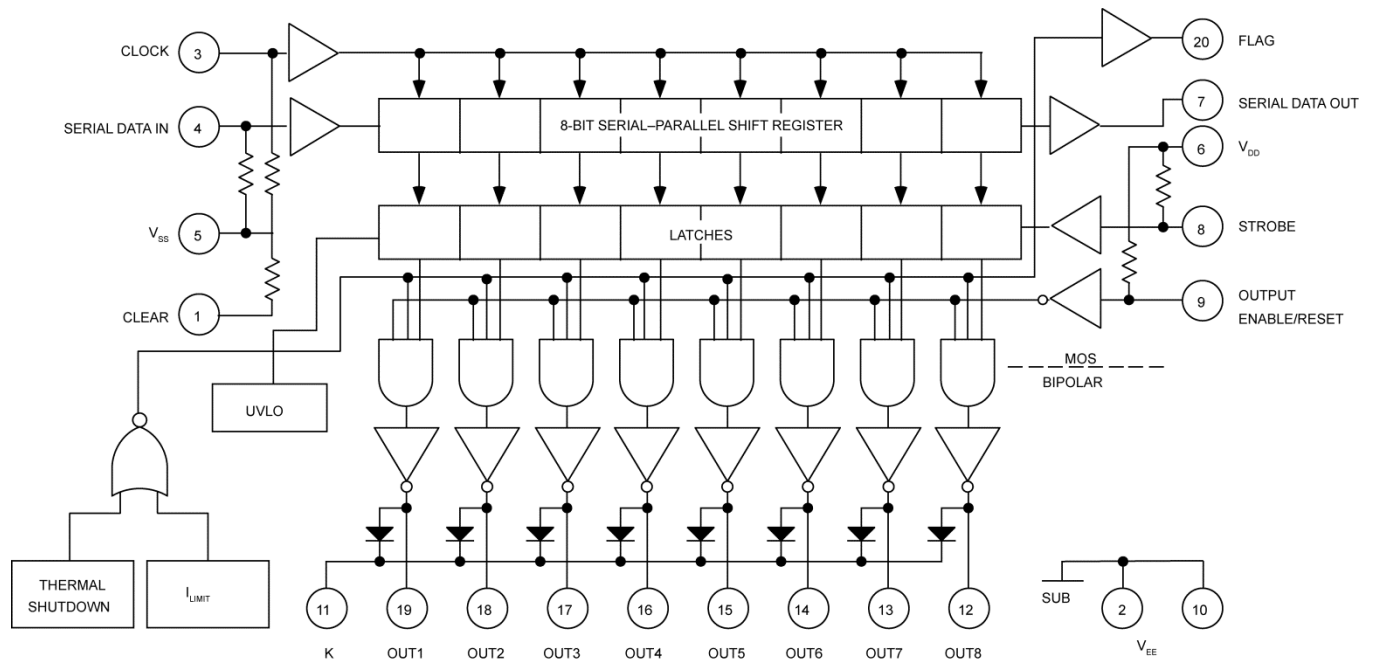
Temperatures above 165°C will shut down the device and activate the error flag. The UVLO circuit prevents operation at low V_{DD} ; hysteresis of 0.5V is provided.

Datasheets and support documentation are available on Micrel's web site at: www.micrel.com.

Features

- 3.3MHz minimum data input rate
- Output current shutdown (500mA typical)
- Undervoltage lockout
- Thermal shutdown
- Output fault flag
- CMOS, PMOS, NMOS, and TTL compatible
- Internal pull-up/pull-down resistors
- Low-power CMOS logic and latches
- High-voltage current sink outputs
- Output transient-protection diodes
- Single or split supply operation

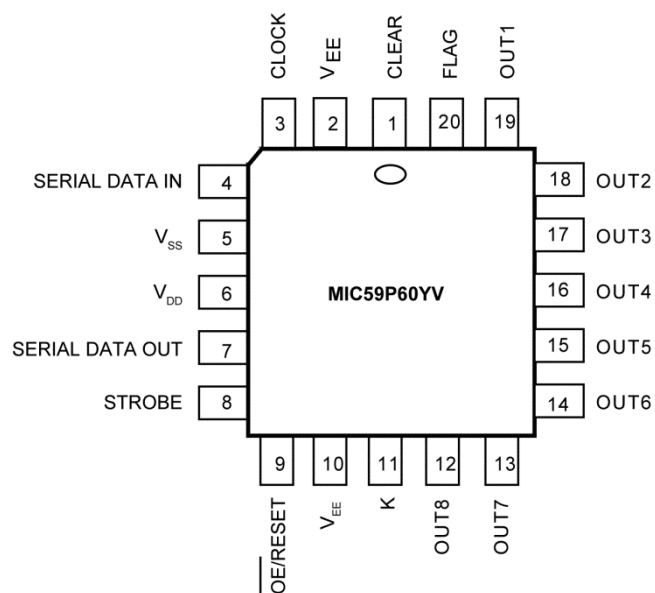
Functional Diagram



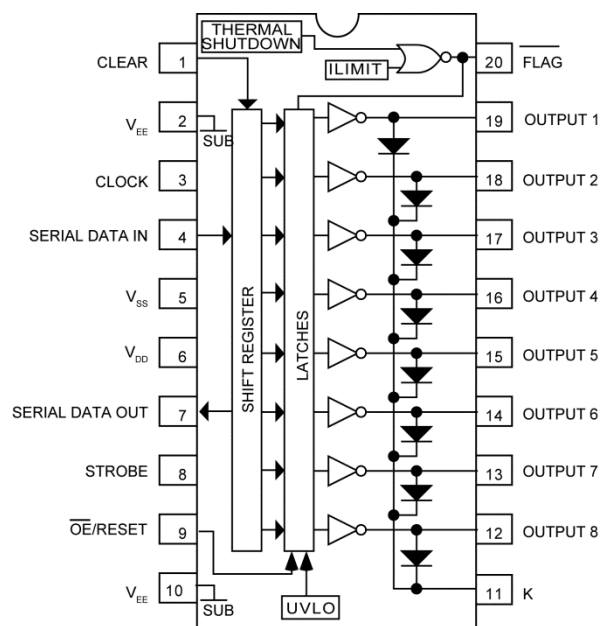
Ordering Information

Part Number	Junction Temperature Range	Package	Pb-Free
MIC59P60YN	-40°C to +85°C	20-Pin Plastic DIP	√
MIC59P60YV	-40°C to +85°C	20-Pin PLCC	√
MICP60YWM	-40°C to +85°C	20-Pin Wide SOIC	√

Pin Configuration



20-Pin PLCC (V)
(Top View)



20-Pin PDIP (N)
20-Pin Wide SOIC (WM)
(Top View)

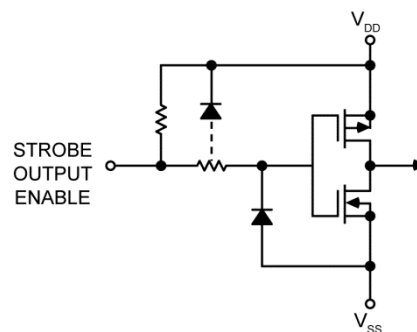
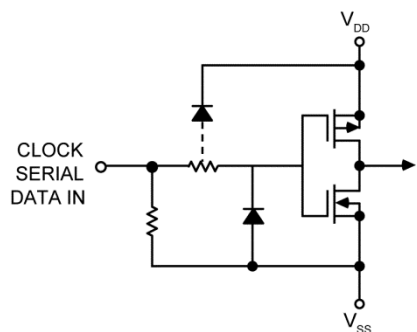
Pin Description

Pin Number	Pin Name	Pin Function
1	CLEAR	Sets All Latches OFF (open).
2, 10	VEE	Output Ground (Substrate). Most negative voltage in the system connects here.
3	CLOCK	Serial Data Clock. A CLEAR must also be clocked into the latches.
4	SERIAL DATA IN	Serial Data Input pin.
5	VSS	Logic reference (Ground) pin.
6	VDD	Logic Positive Supply voltage.
7	SERIAL DATA OUT	Serial Data Output pin. (Flow through).
8	STROBE	Output Strobe pin. Loads output latches when High. A STROBE is needed to CLEAR latches.
9	OE / RESET	When low, outputs are active. When high, device is inactive and reset from a fault condition. An under voltage condition emulates a high OE/RESET input.

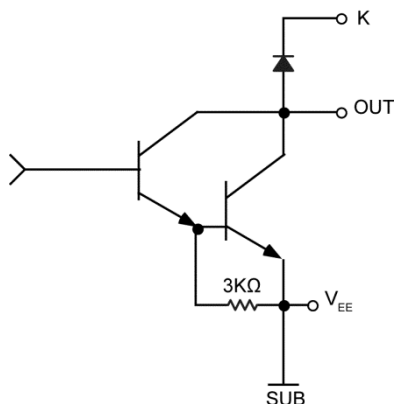
Pin Description (Continued)

Pin Number	Pin Name	Pin Function
11	K	Transient suppression diode's cathode common pin.
12 – 19	OUT N	Open collector outputs 8 through 1.
20	FLAG	Error flag. Open-collector output is low upon overcurrent or overtemperature fault. $\overline{\text{OE/RESET}}$ must be pulled high to reset the flag and fault condition.

Typical Inputs



Typical Output Driver



Absolute Maximum Ratings⁽¹⁾

Output Voltage (V_{CE})	+80V
Output Voltage ($V_{CE(SUS)}$) ⁽³⁾	+50V
Supply Voltage (V_{DD}) with reference to V_{SS}	+15V
Supply Voltage (V_{DD}) with reference to V_{EE}	+25V
Emitter Supply Voltage (V_{EE})	–20V
Input Voltage Range (V_{IN})	–0.3V to V_{DD} +0.3V
Protective Current ⁽⁴⁾	1.5A
Storage Temperature Range (T_S)	–65°C to +150°C
ESD Rating ⁽⁵⁾⁽⁶⁾	ESD Sensitive

Operating Ratings⁽²⁾

Package Power Dissipation, P_D	
Plastic DIP (N)	2.0W
Derate above $T_A = +25^\circ\text{C}$	20mW/°C
PLCC (V)	1.4W
Derate above $T_A = +25^\circ\text{C}$	16mW/°C
Wide SOIC (WM)	1.2W
Derate above $T_A = +25^\circ\text{C}$	12mW/°C
Operating Temperature Range (T_A)	–40°C to +85°C

Electrical Characteristics⁽⁷⁾

$V_{DD} = 5V$, $V_{SS} = V_{EE} = 0V$; $T_A = +25^\circ\text{C}$, unless noted.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
I _{CEX}	Output Leakage Current	V _{OUT} = 80V			50	μA
		V _{OUT} = 80V, T _A = 70°C		100		
V _{CE(SAT)}	Collector-Emitter Saturation Voltage	I _{OUT} = 100mA		0.9	1.1	V
		I _{OUT} = 200mA		1.1	1.3	
		I _{OUT} = 350mA		1.3	1.6	
V _{CE(SUS)}	Collector-Emitter Sustaining Voltage	I _{OUT} = 350mA, L = 2mH	50			V
V _{IN(0)}	Input Voltage				1.0	V
V _{IN(1)}		V _{DD} = 12V	10.5			V
		V _{DD} = 10V	8.5			
		V _{DD} = 5V ⁽⁸⁾	3.5			
R _{IN}	Input Resistance	V _{DD} = 12V	50	200		kΩ
		V _{DD} = 10V	50	300		
		V _{DD} = 5V	50	600		
I _{OL}	Flag Output Current	V _{OL} = 0.4V		15		mA
I _{OH}	Flag Output Leakage			50		nA

Notes:

- Exceeding the absolute maximum ratings may damage the device.
- The device is not guaranteed to function outside its operating ratings.
- For inductive load applications.
- Each channel. VEE connection must be designed to minimize inductance and resistance.
- Devices are input-static protected but can be damaged by extremely high static charges.
- Devices are ESD sensitive. Handling precautions are recommended. Human body model, 1.5k Ω in series with 100pF.
- Specification for packaged product only
- Operation of these devices with standard TTL or DTL may require the use of appropriate pull-up resistors to insure a minimum logic "1".

Electrical Characteristics⁽⁷⁾

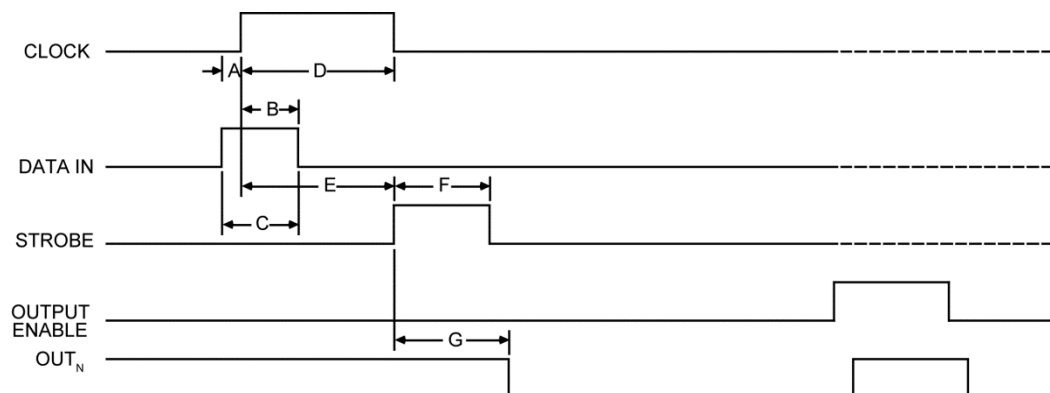
$V_{DD} = 5V$, $V_{SS} = V_{EE} = 0V$; $T_A = +25^{\circ}C$, unless noted.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
I _{DD(ON)}	Supply Current	All Drivers ON, V _{DD} = 12V		6.4	10.0	mA
		All Drivers ON, V _{DD} = 10V		6.0	9.0	
		All Drivers ON, V _{DD} = 5V		4.6	7.5	
I _{DD(1 OUTPUT)}		One Driver ON, All others OFF, V _{DD} = 12V		3.1	4.5	mA
		One Driver ON, All others OFF, V _{DD} = 10V		2.9	4.5	
		One Driver ON, All others OFF, V _{DD} = 5V		2.3	3.6	
I _{DD(OFF)}		All Drivers OFF, V _{DD} = 12V		2.6	4.2	mA
		All Drivers OFF, V _{DD} = 10V		2.4	3.6	
		All Drivers OFF, V _{DD} = 5V		1.9	3.0	
I _R	Clamp Diode Leakage Current	V _R = 80V			50	μA
V _F	Clamp Diode Forward Voltage	I _F = 350mA		1.7	2.0	V
I _{LIM}	Overcurrent Shutdown Threshold			500		mA
V _{SU}	Start-Up Voltage	Note 9	3.5	4.0	4.5	V
V _{DD MIN}	Minimum Supply (V _{DD})		3.0	3.5	4.0	V
	Thermal Shutdown			165		°C
	Thermal Shutdown Hysteresis			10		°C

Note:

9. Undervoltage lockout is guaranteed to release device at no more than 4.5V, and disable the device at no less than 3.0V.

Test Circuit



Timing Conditions

(T_A = +25°C, Logic Levels are V_{DD} and V_{SS}, V_{DD} = 5V)





A. Typical data set-up time before clock pulse (data set-up time).....	75ns
B. Minimum data hold time after clock pulse (data hold time).....	75ns
C. Minimum data pulse width	150ns
D. Minimum clock pulse width.....	150ns
E. Minimum time between clock activation and strobe	300ns
F. Minimum strobe pulse width	100ns
G. Typical time between strobe activation and output transition	500ns

SERIAL DATA present at the input is transferred to the shift register on the logic "0" to logic "1" transition of the CLOCK input pulse. On succeeding CLOCK pulses, the registers shift data information towards the SERIAL DATA OUTPUT. The SERIAL DATA must appear at the input prior to the rising edge of the CLOCK input waveform. Holding CLEAR high results in a data logic "0" being clocked into the shift register, turning off respective channels.

Information present at any register is transferred to its respective latch when the STROBE is high (serial-to-parallel conversion). The latches will continue to accept new data as long as the STROBE is held high. Applications where the latches are bypassed (STROBE tied high) will require that the ENABLE input be high to prevent invalid output states.

When the ENABLE input is high, all of the output buffers are disabled (OFF) without affecting information stored in the latches or shift register. With the ENABLE input low, the outputs are controlled by the state of the latches. A positive OE/RESET pulse resets the FLAG and the output after a current shutdown fault. Over-temperature faults are not latched and require no reset pulse.

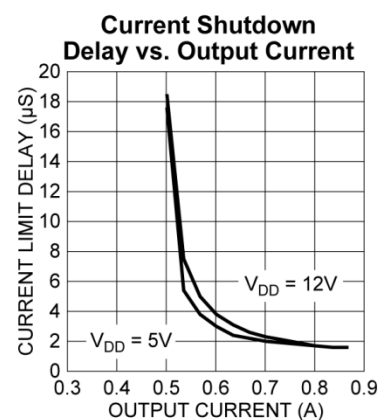
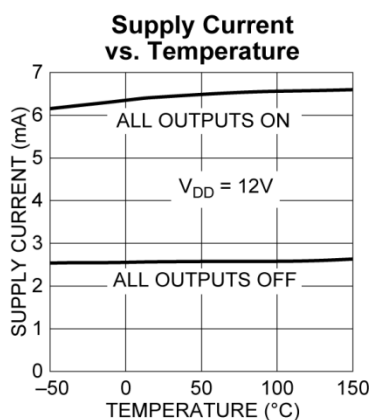
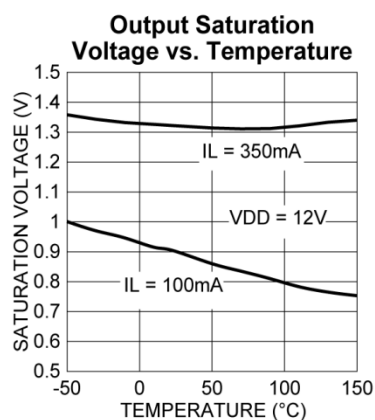
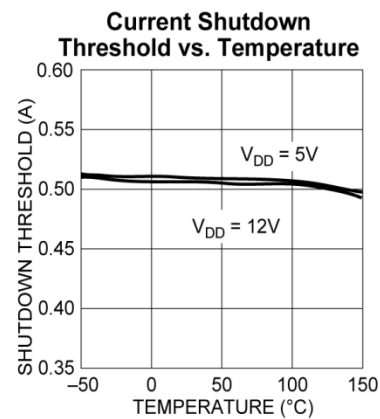
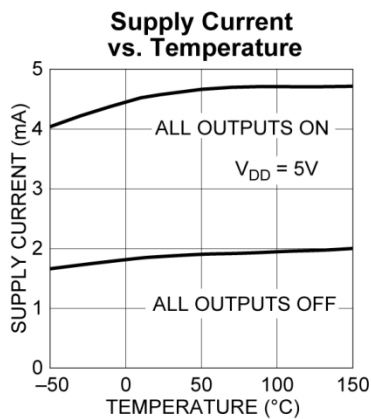
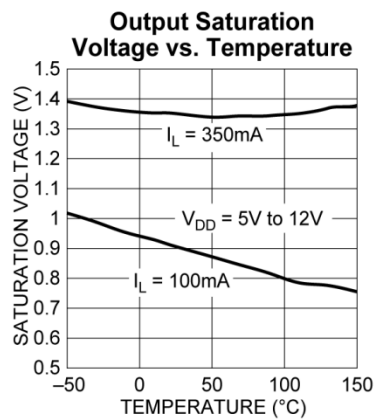
MIC59P60 Truth Table

Serial Data Input	Clear Input	Clock Input	Shift Register Contents	Serial Data Output	Strobe Input	Latch Contents	Output Enable	Output Contents
			I ₁ I ₂ I ₃ I ₈			I ₁ I ₂ I ₃ I ₈		I ₁ I ₂ I ₃ I ₈
H			H R ₁ R ₂ R ₇	R ₇				
L			L R ₁ R ₂ R ₇	R ₇				
X			R ₁ R ₂ R ₃ R ₈	R ₈				
	H		O O O O	L				
			X X X X	X	L	R ₁ R ₂ R ₃ R ₈		
			P ₁ P ₂ P ₃ P ₈	P ₈	H	P ₁ P ₂ P ₃ P ₈	L	P ₁ P ₂ P ₃ P ₈
						X X X X	H	H H H H

Note:

L = Low Logic Level
 H = High Logic Level
 X = Irrelevant
 P = Present State
 R = Previous State
 O = Output OFF

Typical Characteristics



Maximum Allowable Duty Cycle (Plastic DIP)

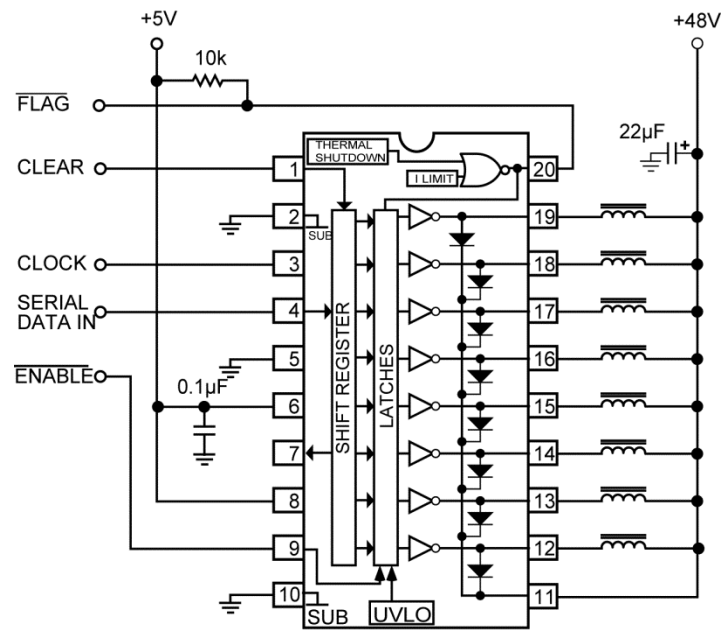
$V_{DD} = 5.0V$

Number of Outputs ON ($I_{OUT} = 200mA$ $V_{DD} = 5.0V$)	Max. Allowable Duty Cycle at Ambient Temperature of				
	25°C	40°C	50°C	60°C	70°C
8	85%	72%	64%	55%	46%
7	97%	82%	73%	63%	53%
6	100%	96%	85%	73%	62%
5	100%	100%	100%	88%	75%
4	100%	100%	100%	100%	93%
3	100%	100%	100%	100%	100%
2	100%	100%	100%	100%	100%
1	100%	100%	100%	100%	100%

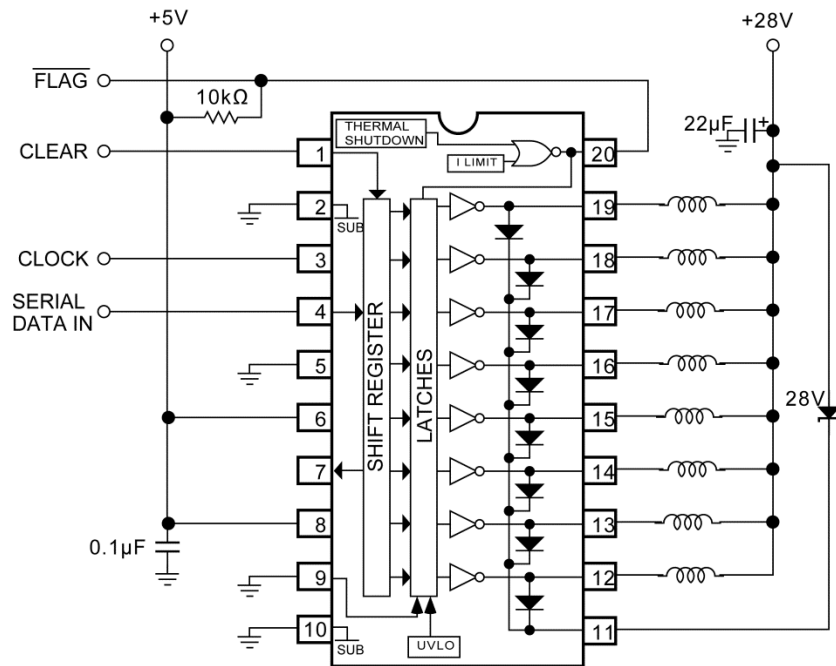
$V_{DD} = 12V$

Number of Outputs ON ($I_{OUT} = 200mA$ $V_{DD} = 12V$)	Max. Allowable Duty Cycle at Ambient Temperature of				
	25°C	40°C	50°C	60°C	70°C
8	80%	68%	60%	52%	44%
7	91%	77%	68%	59%	50%
6	100%	90%	79%	69%	58%
5	100%	100%	95%	82%	69%
4	100%	100%	100%	100%	86%
3	100%	100%	100%	100%	100%
2	100%	100%	100%	100%	100%
1	100%	100%	100%	100%	100%

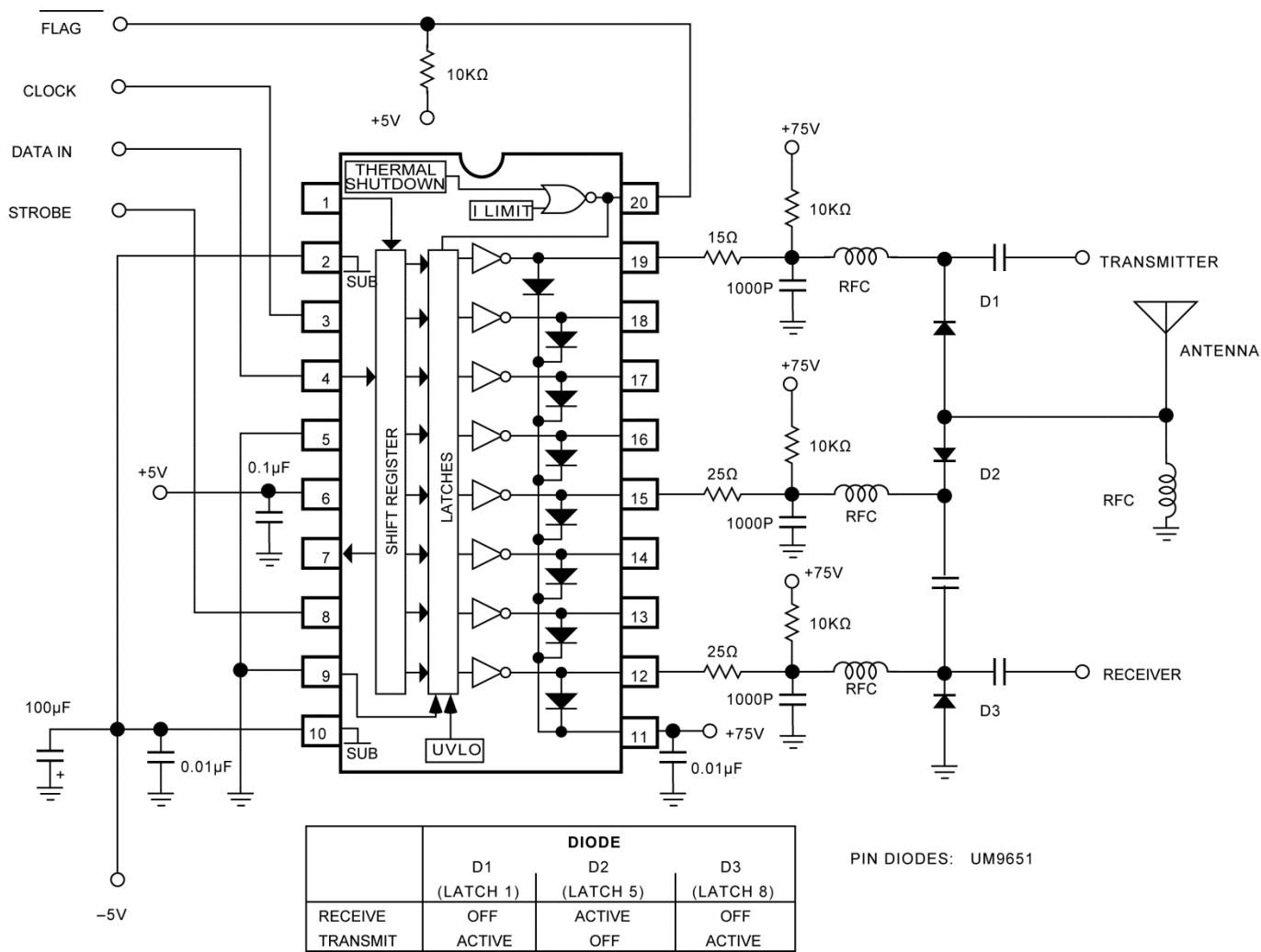
Typical Application



Protected Solenoid Driver with Output Enable

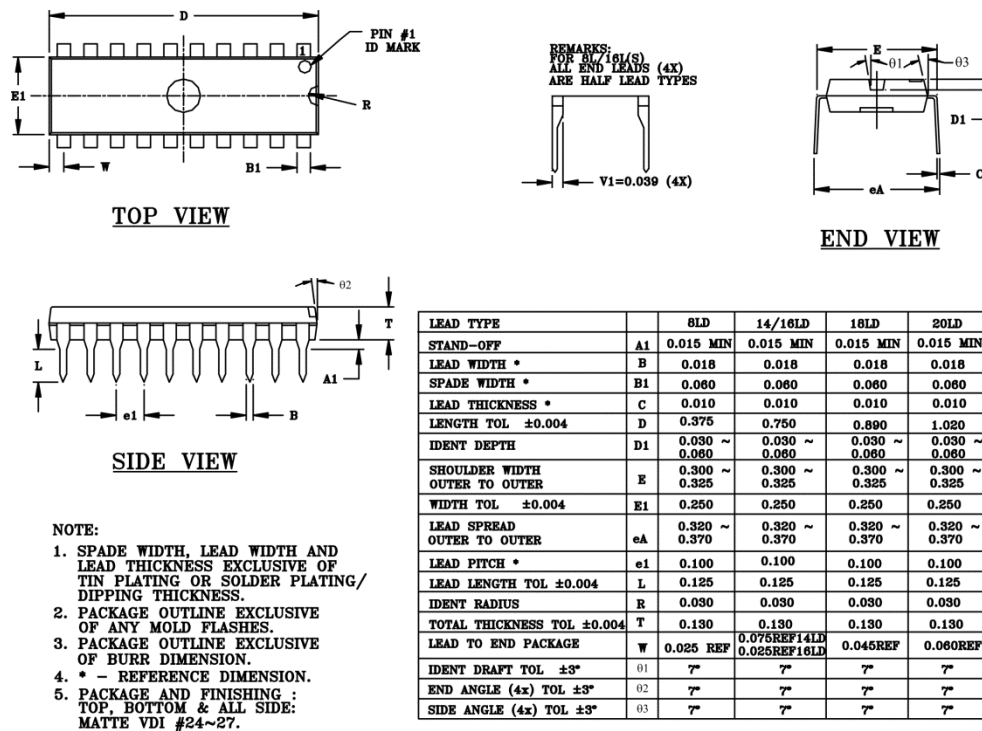


Hammer Driver

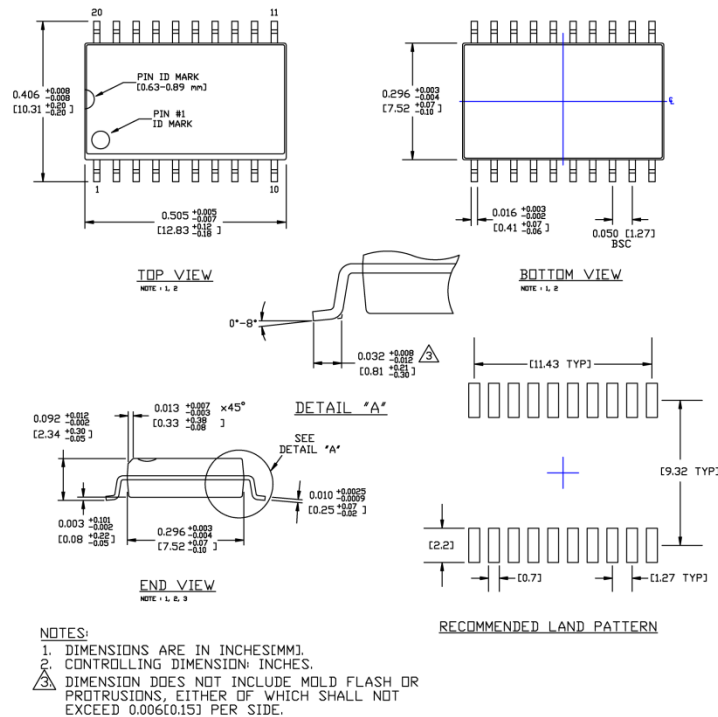


Protected Negative/Positive PIN Diode Driver Transmit/Receive Switch

Package Information and Recommended Landing Pattern⁽¹⁰⁾



20-Pin 300mil Plastic PDIP (N)

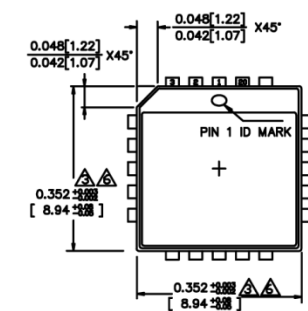


20-Pin Wide SOIC (WM)

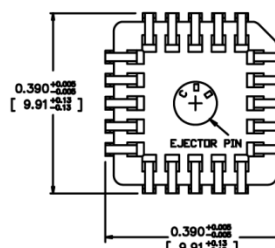
Note:

10. Package information is correct as of the publication date. For updates and most current information, go to www.micrel.com.

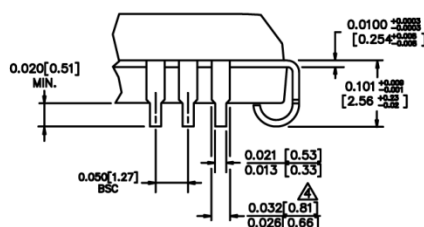
Package Information and Recommended Landing Pattern⁽¹⁰⁾ (Continued)



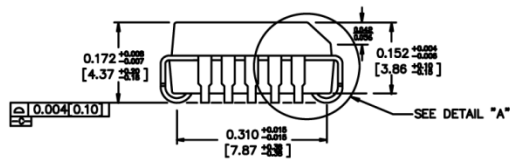
TOP VIEW



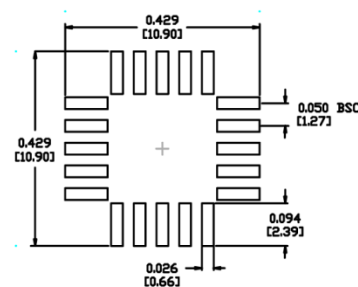
BOTTOM VIEW



DETAIL "A"



SIDE VIEW



RECOMMENDED LAND PATTERN

- NOTES:**
1. DIMENSIONS ARE IN INCHES [MM].
 2. CONTROLLING DIMENSION: INCHES.
 3. DIMENSION DOES NOT INCLUDE MOLD FLASH OR PROTRUSIONS, EITHER OF WHICH SHALL NOT EXCEED 0.008 [0.203].
 4. LEAD DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION.
 5. MAXIMUM AND MINIMUM SPECIFICATIONS ARE INDICATED AS FOLLOWS: MAX/MIN
 6. PACKAGE TOP DIMENSION MAY BE SLIGHTLY SMALLER THAN BOTTOM DIMENSION.

20-Pin PLCC (V)

MICREL, INC. 2180 FORTUNE DRIVE SAN JOSE, CA 95131 USA
TEL +1 (408) 944-0800 FAX +1 (408) 474-1000 WEB <http://www.micrel.com>

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